

Search Notes



Application/Control No.

10/617,151

Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

GOODIN ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	302	9/2005	jrc
430	165		
430	207.1		
430	273.1		
101	456		
101	46.1		
101	465		
101	466		
101	467		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST SEARCH UPDATED	9/2005	jrc